

**Search Notes**

Application/Control No.

09/742,290

Examiner

Chongshan Chen

Applicant(s)/Patent under  
Reexamination

MODELSKI ET AL.

Art Unit

2162

**SEARCHED**

Class	Subclass	Date	Examiner
707	3	6/12/2005	CC
707	6	6/12/2005	CC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PALM	6/12/2005	CC
EASt search (USPAT, US-PGPUB, IBM_TDB)	6/12/2005	CC